



Designation: E 1552 – 93 (Reapproved 2002)

Standard Test Method for Determining Hafnium in Zirconium and Zirconium Alloys Using the D-C Argon Plasma Spectrometer¹

This standard is issued under the fixed designation E 1552; the number immediately following the designation indicates the year of original adoption or, in the case of revision, the year of last revision. A number in parentheses indicates the year of last reapproval. A superscript epsilon (ϵ) indicates an editorial change since the last revision or reapproval.

1. Scope

1.1 This test method covers the determination of hafnium in zirconium and zirconium alloys in concentrations greater than 0.003 %.

1.2 *This standard does not purport to address all of the safety problems, if any, associated with its use. It is the responsibility of the user of this standard to establish appropriate safety and health practices and determine the applicability of regulatory limitations prior to use.* Specific precautionary statements are given in Section 8.

2. Referenced Documents

2.1 ASTM Standards:

B 349 Specification for Zirconium Sponge and Other Forms of Virgin Metal for Nuclear Application²

B 350 Specification for Zirconium and Zirconium Alloy Ingots for Nuclear Application²

B 351 Specification for Hot-Rolled and Cold-Finished Zirconium and Zirconium Alloy Bars, Rod and Wire for Nuclear Application²

B 352 Specification for Zirconium and Zirconium Alloy Sheet, Strip, and Plate for Nuclear Application²

B 353 Specification for Wrought Zirconium and Zirconium Alloy Seamless and Welded Tubes for Nuclear Service²

B 614 Practice for Descaling and Cleaning Zirconium and Zirconium Alloy Surfaces³

E 50 Practices for Apparatus, Reagents, and Safety Precautions for Chemical Analysis of Metals⁴

E 135 Terminology Relating to Analytical Chemistry for Metals, Ores, and Related Materials⁴

E 1060 Practice for Interlaboratory Testing of Spectrochemical Methods of Analysis⁵

E 1097 Guide for Direct Current Plasma Emission Spectrometry Analysis⁵

3. Terminology

3.1 For definitions of terms used in this test method, refer to Terminology **E 135**.

4. Summary of Test Method

4.1 The sample, in the form of drillings, chips, milling, turnings or powder, is dissolved in dilute hydrofluoric acid (HF). The hafnium content is measured using a d-c argon plasma spectrometer which is calibrated with reference solutions of hafnium in the presence of zirconium. The microprocessor is programmed to display the results in micrograms per millilitre ($\mu\text{g/mL}$).

5. Significance and Use

5.1 When zirconium materials are used in nuclear applications, it is necessary that hafnium, a neutron absorber, be present only at very low concentrations.

5.2 This method is useful in testing materials for compliance with the compositional requirements as given in Specifications **B 349**, **B 350**, **B 351**, **B 352**, and **B 353**.

6. Apparatus

6.1 Plastic Labware:

6.1.1 *Beakers*, 100-mL, disposable, polypropylene, or 125-mL polytetrafluoroethylene (PTFE) are satisfactory.

6.1.2 *Volumetric Flasks*—Linear polyethylene (LPE) or polymethylpentene (PMP) are satisfactory.

NOTE 1—Plastic volumetric flasks change dimension as they age and therefore must be recalibrated periodically.

6.2 *Spectrometer*⁶—*Modified Czerny-Turner*, using an Echelle grating with 30° prism for order separation providing a reciprocal linear dispersion of about 1 Å mm in the 80 to 85th order. The instrument is operated in the sequential mode.

6.3 Excitation Source⁶:

⁶ Spectrometer system manufactured by Applied Research Laboratories, Inc., Valencia, CA 91355, has been found satisfactory.

¹ This test method is under the jurisdiction of ASTM Committee E01 on Analytical Chemistry for Metals, Ores, and Related Materials and is the direct responsibility of Subcommittee E01.06 on Ti, Zr, W, Mo, Ta, Nb, Hf. Current edition approved Oct. 10, 2002. Published September 1993.

² *Annual Book of ASTM Standards*, Vol 02.04.

³ *Annual Book of ASTM Standards*, Vol 3.05.

⁴ *Discontinued*, See, 1997 *Annual Book of ASTM Standards*, Vol 03.05.

⁵ *Annual Book of ASTM Standards*, Vol 03.06.



6.3.1 *D-C Argon Plasma*, formed by a tungsten cathode and two carbon anodes in an inverted “Y” configuration, having a current output of 7 A at 40 V.

6.3.2 Glass spray tube shall be replaced with one made from PTFE or pyrolytic graphite to prevent hydrofluoric acid attack on the glass.

6.4 *Argon*—Commercially available as prepurified gas or liquid is satisfactory.

7. Reagents and Materials

7.1 *Purity and Concentration of Reagents*—The purity and concentration of chemical reagents shall conform to the requirements prescribed in Practices E 50.

7.2 Pure Metals:

7.2.1 *Hafnium Metal or Hafnium Dioxide*, of highest purity available and having a known impurity content.

NOTE 2—Many hafnium materials contain residual zirconium in quantity sufficient to affect the hafnium value.

7.2.2 *Zirconium Metal*, of the highest purity available and having a known hafnium content.

7.3 Reference Materials:

7.3.1 *Standard Reference Materials (SRM)*⁷: Three unalloyed zirconium materials—SRM 1234, 1235, and 1236 containing 46, 95, and 198 ppm hafnium, respectively, and three alloyed zirconium materials—SRM 1237, 1238, and 1239 containing 31, 178, and 77 ppm hafnium, respectively.

7.3.2 Other reference solutions can be prepared by dissolving zirconium metal in HF. A solution of hafnium metal dissolved in HF is added to the zirconium solution to produce the required concentrations.

8. Hazards

8.1 This method involves the use of concentrated hydrofluoric acid. Read and follow label precautions carefully before using.

8.2 Refer to Practices E 50, 7.4.11, for more information.

9. Preparation of Apparatus

9.1 Conduct start-up and wavelength adjustment in accordance with the manufacturer's instructions.

9.1.1 Optimize the hafnium wavelength at 2641.41 Å or 2820.22 Å while introducing the 1-mg/mL solution prepared in 10.2.

9.1.2 Enter the appropriate concentration values (microgram per millilitre) for the high and low reference materials into the microprocessor.

9.2 Replication:

9.2.1 Set the microprocessor to average three integrations at 10 s each.

9.3 Direct Current Plasma—Instrument Parameters:

Current, A	7
Voltage, V	40
Gas	Argon, 99.9 % min
Flow rate, L/min	8
Entrance slits, µm	50 wide by 300 high

Exit slits, µm

25 wide by 300 high

10. Preparation of Calibration Solutions and Specimens

10.1 Preparation of Calibration Solutions:

10.1.1 Weigh 1.0 g SRM to the nearest 1 mg into a plastic beaker. Add 20 mL water and, in small increments, add 10 mL HF (48 %) and cover with a plastic cover. When the reaction subsides, add 2 mL HNO₃ and place the beaker on a steam bath for 10 min to assure complete dissolution of the specimen.

10.1.2 Cool the solution, transfer to a 100-mL plastic volumetric flask, dilute to volume and mix.

10.2 Preparation of Hafnium Solution (1 mg/mL):

10.2.1 *Hafnium Metal*—Weigh 0.1 g of the pure hafnium to the nearest 0.1 mg, into a plastic beaker. Add 20 mL water and, in small increments, add 10 mL HF. Cover with a plastic cover and place beaker on a steam bath until dissolution is complete. Cool the beaker, transfer to a 100-mL plastic volumetric flask, dilute to volume, and mix.

10.2.2 *Hafnium Dioxide*—Weigh 0.1179 g of the pure HfO₂ to the nearest 1 mg into a plastic beaker. Add 30 mL HF, cover with a plastic cover and place the beaker on a steam bath until dissolution is complete. Cool the beaker, transfer to a 100-mL plastic volumetric flask, dilute to volume, and mix.

NOTE 3—Hafnium metal and HfO₂ weights must be correspondingly increased as total hafnium content decreases because of impurity content.

10.3 Preparation of Hafnium Spiking Solutions:

10.3.1 *Solution (100 µg/mL)*—Transfer 10.0 mL of the 1-mg/mL solution, prepared in accordance with 10.2, into a 100-mL plastic volumetric flask, dilute to volume, and mix.

10.3.2 *Solution (10 µg/mL)*—Transfer 10.0 mL of the 100-µg/mL solution, prepared in accordance with 10.3.1, into a 100-mL plastic volumetric flask, dilute to volume and mix.

10.4 Preparation of Synthetic Reference Materials:

10.4.1 For each calibration point required, weigh 0.5 g of the pure zirconium metal to the nearest 1 mg into a plastic beaker. Add 10 mL water and, in small increments, add 5 mL HF (48 %) and cover with a plastic cover. Continue as described in 10.1.1.

10.4.2 Cool the solution and transfer to a 50-mL plastic volumetric flask. Reserve sufficient volume for the hafnium spike.

10.4.3 Transfer known quantities of the appropriate hafnium spiking solution prepared in 10.3 to each flask as given in Table 1.

10.5 Preparation of Specimens:

TABLE 1 Preparation of Synthetic Reference Solutions

Concentration ^A		Concentration of Spiking Solution, µg/mL	Volume of Spiking Solution, mL
ppm	µg/mL		
30 + b ^B	0.3	10	1.5
50 + b	0.5	10	2.5
100 + b	1.0	10	5.0
200 + b	2.0	10	10.0
500 + b	5.0	100	2.5

^A Values given in parts per million (ppm) and micrograms per millilitre (µg/mL) are only true if the zirconium matrix material is hafnium-free. If hafnium is present in the matrix material, its value must be added to the spiked value.

^B The letter b indicates blank.

⁷ Available from National Institute of Standards and Technology, Standard Reference Materials Program, Building 202, Room 204, Gaithersburg, MD 20899.